

General Description

The HXYG15H06S use advanced SGT MOSFET technology to provide low RDS(ON), low gate charge, fast switching and excellent avalanche characteristics.

This device is specially designed to get better ruggedness and suitable to use in

D2 D2 D1 D1 G2 G2 G1 S1

SOP-8

General Features

V_{DS} =60V I_D =15A

 $R_{DS(ON)}$ < 15m Ω @ V_{GS}=10V

D1 D1 D2 D2 80 70 60 50 10 20 30 40 S1 G1 S2 G2

Applications

Consumer electronic power supply Motor control

Synchronous-rectification Isolated DC

Synchronous-rectification applications

Dual N-Channel MOSFET

Package Marking and Ordering Information

Product ID	Pack	Marking	Qty(PCS)
HXYG15H06S	SOP-8		3000

Absolute Maximum Ratings at T_j=25°C unless otherwise noted

Parameter	Symbol	Value	Unit
Drain source voltage	VDS	60	V
Gate source voltage	VGS ±20		
Continuous drain current ¹⁾	ID	15	А
Pulsed drain current ²⁾	ID, pulse	180	А
Power dissipation ³⁾	P _D	60	W
Single pulsed avalanche energy ⁵⁾	EAS	36	mJ
Operation and storage temperature	Tstg, Tj	-55 to 150	°C
Thermal resistance, junction-case	RθJC	2.5	°C/W



Electrical Characteristics (T_J=25°C unless otherwise specified)

Symbol	Parameter	Test Condition	Min.	Тур.	Max.	Units
Off Charac	cteristic					
V _{(BR)DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =250µA	60	-	_	V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =60V, V _{GS} =0V,	-	-	1.0	μA
I _{GSS}	Gate to Body Leakage Current	V _{DS} =0V, V _{GS} = ±20V	-	-	±100	nA
On Charac	cteristics					
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$	1.0	1.6	2.5	V
	Static Drain-Source on-Resistance	V _{GS} =10V, I _D =20A	-	12	15	mΩ
$R_{DS(on)}$		V _{GS} =4.5V, I _D =10A	-	15	20	
Dynamic (Characteristics					
C _{iss}	Input Capacitance	V _{DS} =25V, V _{GS} =0V, f=1.0MHz	-	930	-	pF
Coss	Output Capacitance		-	230	-	pF
Crss	Reverse Transfer Capacitance		-	8	-	pF
Qg	Total Gate Charge	V _{DS} =30V, I _D =20A, V _{GS} =10V	-	22	-	nC
Q _{gs}	Gate-Source Charge		-	4.5	-	nC
Q_{gd}	Gate-Drain("Miller") Charge	VGS-10V	_	3.5	_	nC
Switching	Characteristics					
t _{d(on)}	Turn-on Delay Time		-	4.5	-	ns
t _r	Turn-on Rise Time	V _{DD} =30V, I _D =20A,	-	2.7	-	ns
t _{d(off)}	Turn-off Delay Time	R_G =1.6 Ω , V_{GS} =10 V	-	13.8	-	ns
t _f	Turn-off Fall Time		-	2.7	_	ns
Drain-Sou	rce Diode Characteristics and Maxim	um Ratings				
Is	Maximum Continuous Drain to Source Diode Forward Current		-	-	15	Α
I _{SM}	Maximum Pulsed Drain to Source Dio	um Pulsed Drain to Source Diode Forward Current		-	180	Α
V_{SD}	Drain to Source Diode Forward Voltage	V _{GS} =0V, I _S =30A	-	-	1.2	V
t _{rr}	Body Diode Reverse Recovery Time	T -05°C	-	18	-	ns
Qrr	Body Diode Reverse Recovery Charge	T _J =25℃, I _F =20A,dI/dt=100A/μs	-	12	-	nC

Notes:1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature

- 2. EAS condition: TJ=25 $^{\circ}\text{C}$, VDD=30V, VG=10V, RG=25 Ω , L=0.5mH, IAS=12A
- 3. Pulse Test: Pulse Width≤300µs, Duty Cycle≤0.5%



Typical Performance Characteristics

Figure1: Output Characteristics

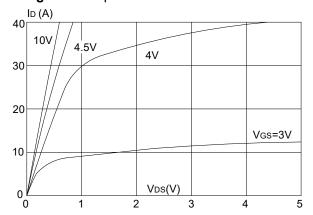


Figure 3:On-resistance vs. Drain Current

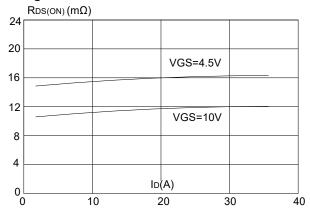


Figure 5: Gate Charge Characteristics

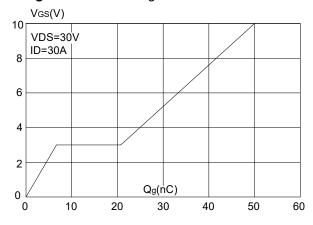


Figure 2: Typical Transfer Characteristics

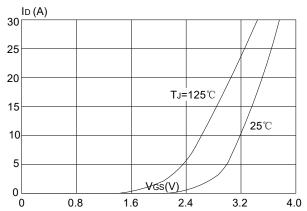


Figure 4: Body Diode Characteristics

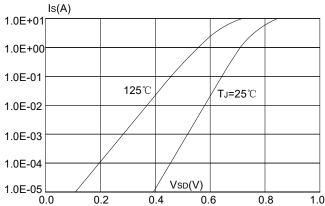


Figure 6: Capacitance Characteristics

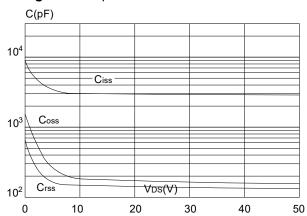


Figure 7: Normalized Breakdown Voltage vs. Junction Temperature

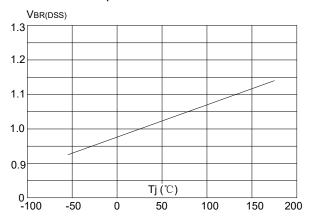


Figure 9: Maximum Safe Operating Area

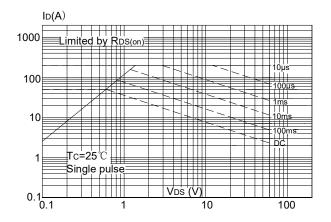


Figure.11: Maximum Effective Transient Thermal Impedance, Junction-to-Case

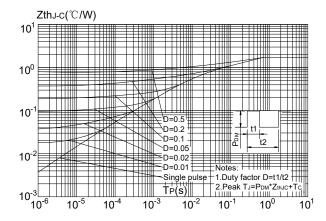


Figure 8: Normalized on Resistance vs. Junction Temperature

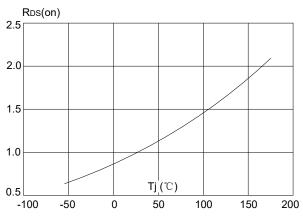
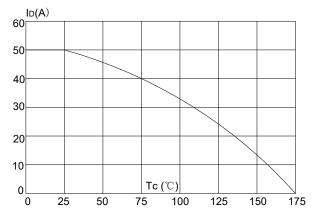
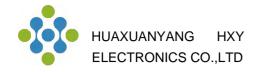
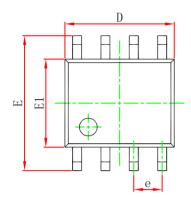


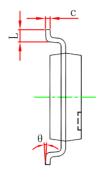
Figure 10: Maximum Continuous Drain Current vs. Case Temperature

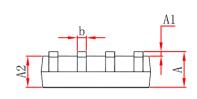




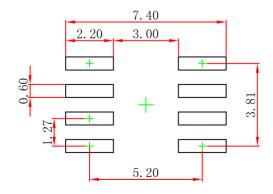
SOP-8 Package Outline Dimensions







Symbol	Dimensions In Millimeters		Dimensions In Inches		
Symbol	Min	Max	Min	Max	
A	1. 350	1.750	0.053	0.069	
A1	0.100	0. 250	0.004	0.010	
A2	1.350	1.550	0.053	0.061	
b	0.330	0.510	0.013	0.020	
c	0.170	0. 250	0.007	0.010	
D	4.800	5.000	0.189	0. 197	
e	1. 270 (BSC)	0.050 (BSC)		
E	5.800	6. 200	0. 228	0.244	
E1	3.800	4.000	0.150	0. 157	
L	0.400	1. 270	0.016	0.050	
θ	0°	8°	0°	8°	



- Note: 1.Controlling dimension:in millimeters.
- 2.General tolerance:± 0.05mm.
 3.The pad layout is for reference purposes only.

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